

Notice of References Cited

Application/Control No.

09/973,838

Applicant(s)/Patent Under

Reexamination

YANAGISAWA ET AL.

Examiner

Fritz Alphonse

Art Unit

2675

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,818,429	10-1998	Tanaka et al.	345/173
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	M	US-			

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